Issue Classification



CLASS

ORIGINAL

Application/Control No	

SUBCLASS

Examiner LEON-VIET Q NGUYEN

CLAIMED

Applicant(s)/Patent Under Reexamination
YOSHIDA, SHOUSEI
Art Unit
2611

NON-CLAIMED

INTERNATIONAL CLASSIFICATION

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(Assistant Examin	sistant Examiner) (Date)													
/DAVID C PAYNE/ Supervisory Patent Examiner.Art Unit 2611								03/22	/2010	0.0	6. Print Cla	im(s)	O.G. Prin	t Figure
(Primary Examiner)							(Da	ate)		1		3		

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